

Si9430DY*

Single P-Channel Enhancement Mode MOSFET

General Description

This P-Channel Enhancement Mode MOSFET is produced using Fairchild Semiconductor's advance process that has been especially tailored to minimize on-state resistance and yet maintain superior switching performance.

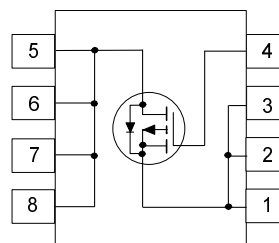
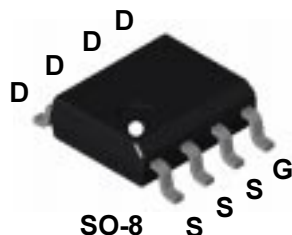
This device is well suited for low voltage and battery powered applications where low in-line power loss and fast switching are required.

Applications

- Battery switch
- Load switch
- Motor controls

Features

- -5.8 A, -20 V. $R_{DS(on)} = 0.050 \Omega @ V_{GS} = -10 V$
 $R_{DS(on)} = 0.090 \Omega @ V_{GS} = -4.5 V$.
- Low gate charge.
- Fast switching speed.
- High power and current handling capability.



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter	Ratings	Units
V _{DSS}	Drain-Source Voltage	-20	V
V _{GSS}	Gate-Source Voltage	±20	V
I _D	Drain Current - Continuous (Note 1a)	-5.8	A
	- Pulsed	-20	
P _D	Power Dissipation for Dual Operation (Note 1a) (Note 1b) (Note 1c)	2.5	W
		1.2	
		1.0	
T _J , T _{STG}	Operating and Storage Junction Temperature Range	-55 to +150	°C

Thermal Characteristics

R _{θJA}	Thermal Resistance, Junction-to-Ambient	50	°C/W
R _{θJC}	Thermal Resistance, Junction-to-Case (Note 1)	25	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
9430	Si9430DY	13"	12mm	2500 units

* Die and manufacturing source subject to change without prior notification.

Electrical Characteristics

$T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
Off Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = -250\ \mu\text{A}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$, Referenced to 25°C		-16		mV/ $^\circ\text{C}$
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -16\text{ V}, V_{GS} = 0\text{ V}$ $V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V}, T_J = 70^\circ\text{C}$			-1 -5	μA
I_{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 20\text{ V}, V_{DS} = 0\text{ V}$			100	nA
I_{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -20\text{ V}, V_{DS} = 0\text{ V}$			-100	nA

On Characteristics (Note 2)

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\ \mu\text{A}$	-1.0			V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250\ \mu\text{A}$, Referenced to 25°C		3.5		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain-Source On-Resistance	$V_{GS} = -10\text{ V}, I_D = -5.3\text{ A}$ $V_{GS} = -6\text{ V}, I_D = -3.6\text{ A}$ $V_{GS} = -4.5\text{ V}, I_D = -2\text{ A}$		0.038 0.046 0.064	0.050 0.060 0.090	Ω
$I_{D(on)}$	On-State Drain Current	$V_{GS} = -10\text{ V}, V_{DS} = -5\text{ V}$ $V_{GS} = -4.5\text{ V}, V_{DS} = -5\text{ V}$	-20 -5			A
g_{FS}	Forward Transconductance	$V_{DS} = -15\text{ V}, I_D = -5.3\text{ A}$		10		S

Dynamic Characteristics

C_{iss}	Input Capacitance	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$		950		pF
C_{oss}	Output Capacitance			610		pF
C_{rss}	Reverse Transfer Capacitance			220		pF

Switching Characteristics (Note 2)

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = -10\text{ V}, I_D = -1\text{ A}, R_L = 10\ \Omega$ $V_{GS} = -10\text{ V}, R_{GEN} = 6\ \Omega$		9	30	ns
t_r	Turn-On Rise Time			21	60	ns
$t_{d(off)}$	Turn-Off Delay Time			21	120	ns
t_f	Turn-Off Fall Time			8	100	ns
t_{rr}	Drain-Source Reverse Recovery Time	$I_F = -2.4\text{ A}, di/dt = 100\text{A}/\mu\text{s}$			100	nS
Q_g	Total Gate Charge	$V_{DS} = -10\text{ V}, I_D = -5.3\text{ A},$ $V_{GS} = -10\text{ V}$		27	50	nC
Q_{gs}	Gate-Source Charge			3		nC
Q_{gd}	Gate-Drain Charge			9		nC

Drain-Source Diode Characteristics and Maximum Ratings

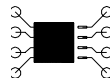
I_S	Maximum Continuous Drain-Source Diode Forward Current			-2.4	A
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = -2.4\text{ A}$ <small>(Note 2)</small>		-0.85 -1.2	V

Notes:

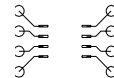
1: $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.



a) 50°C/W when mounted on a 1 in² pad of 2 oz. copper.



b) 105°C/W when mounted on a 0.04 in² pad of 2 oz. copper.



c) 125°C/W on a minimum mounting pad.

Scale 1 : 1 on letter size paper

2: Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2.0\%$

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